

Notice of References Cited

Application/Control No.

10/693,169

Applicant(s)/Patent Under
Reexamination
WALLACE ET AL.

Examiner

VENKATESH HALIYUR

Art Unit

2419

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,266,528	07-2001	Farzaneh, Farhad	455/423
*	B	US-6,278,726	08-2001	Mesecher et al.	375/148
*	C	US-2001/0038666	11-2001	Mesecher et al.	375/148
*	D	US-2002/0105928 A1	08-2002	Kapoor et al.	370/334
*	E	US-2003/0016640	01-2003	Onggosanusi et al.	370/335
*	F	US-2003/0048856 A1	03-2003	Ketchum et al.	375/260
*	G	US-2003/0043732 A1	03-2003	Walton et al.	370/208
*	H	US-2003/0108117 A1	06-2003	Ketchum et al.	375/295
*	I	US-2003/0112880 A1	06-2003	Walton et al.	375/260
*	J	US-6,574,271	06-2003	Mesecher et al.	375/148
*	K	US-2003/0128658 A1	07-2003	Walton et al.	370/208
*	L	US-2003/0125040 A1	07-2003	Walton et al.	455/454
*	M	US-2003/0189972	10-2003	Berens et al.	375/148

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/693,169		Applicant(s)/Patent Under Reexamination WALLACE ET AL.	
	Examiner VENKATESH HALIYUR		Art Unit 2419	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0185310 A1	10-2003	Ketchum et al.	375/259
*	B	US-2003/0235255 A1	12-2003	Ketchum et al.	375/285
*	C	US-6,690,660	02-2004	Kim et al.	370/335
*	D	US-6,751,187 B2	06-2004	Walton et al.	370/210
*	E	US-6,760,388 B2	07-2004	Ketchum et al.	375/295
*	F	US-6,795,424 B1	09-2004	Kapoor et al.	370/343
*	G	US-7,020,110 B2	03-2006	Walton et al.	370/334
*	H	US-7,072,413 B2	07-2006	Walton et al.	375/267
*	I	US-7,072,410	07-2006	Monsen, Peter	375/260
*	J	US-7,088,671	08-2006	Monsen, Peter	370/203
*	K	US-7,197,084 B2	03-2007	Ketchum et al.	375/296
*	L	US-7,206,354	04-2007	Wallace et al.	375/267
*	M	US-7,248,841	07-2007	Agee et al.	455/101

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/693,169

Applicant(s)/Patent Under
Reexamination
WALLACE ET AL.

Examiner

VENKATESH HALIYUR

Art Unit

2419

Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,254,171	08-2007	Hudson, John E	375/229
*	B	US-7,342,912 B1	03-2008	Kerr et al.	370/347
*	C	US-7,421,039	09-2008	Malaender et al.	375/304
*	D	US-7,103,325	09-2006	Jia et al.	455/101
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.